Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/550,387	FUCHIKAMI ET AL.	
Examiner	Art Unit	
Jennifer Y. Cho	1621	

	SEARCHED				
Class	Subclass	Date	Examiner		
560	227	3/1/2007	1C		
562	520	3/1/2007	JC .		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN Search	3/1/2007	JC .
STN Search	3/1/2007	кs
Inventor Search	3/1/2007	JC
East Search	3/1/2007	JC